

Search Notes

Application/Control No.

10/070,074

Examiner

Phung T. Nguyen

Applicant(s)/Patent under
Reexamination

HEISE ET AL.

Art Unit

2632

SEARCHED

Class	Subclass	Date	Examiner
340	438	6/2/2005	PTN
	933		
	426.15		
	461		
	10.6		
701	1		
	29		
345	173		
	349	6/2/2005	PTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	461	6/2/2005	PTN
	933		
345	173	6/2/2005	PTN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/6/2004	PTN
EAST	6/2/2005	PTN